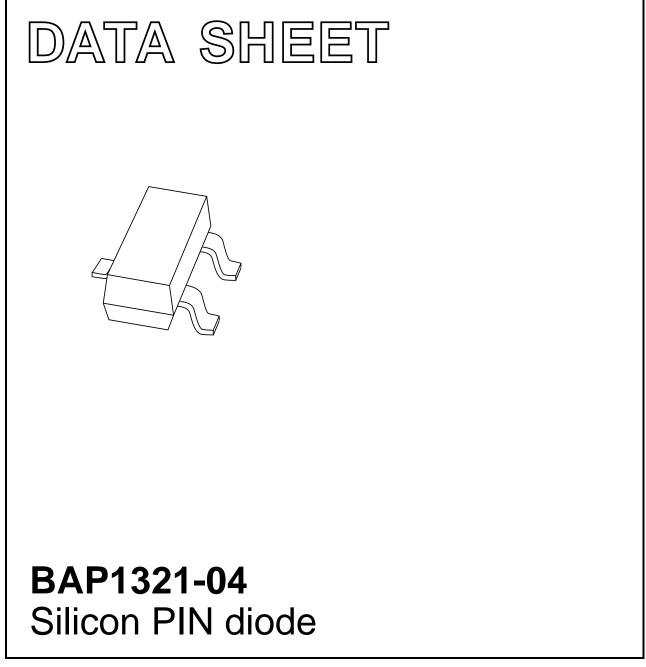
DISCRETE SEMICONDUCTORS



Product specification

2001 Apr 17



Product specification

Silicon PIN diode

BAP1321-04

FEATURES

- High voltage, current controlled
- RF resistor for RF attenuators and switches
- Low diode capacitance
- Low diode forward resistance
- Very low series inductance
- For applications up to 3 GHz.

APPLICATIONS

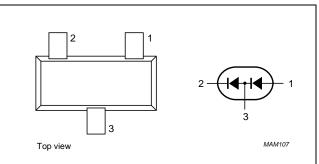
• RF attenuators and switches.

DESCRIPTION

Two planar PIN diodes in series configuration in a SOT23 small SMD plastic package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------------|
| 1 | anode |
| 2 | cathode |
| 3 | common connection |



Marking code: 6Fp.

Fig.1 Simplified outline (SOT23) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|----------------------------|--------------------------|------|------|------|
| Per diode | | | | | |
| V _R | continuous reverse voltage | | - | 60 | V |
| I _F | continuous forward current | | _ | 100 | mA |
| P _{tot} | total power dissipation | $T_s \le 90 \ ^{\circ}C$ | - | 250 | mW |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| Tj | junction temperature | | -65 | +150 | °C |

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ELECTRICAL CHARACTERISTICS

 $T_j = 25 \ ^{\circ}C$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|--------------------------------|--------------------------|--|-------|-------|------|
| Per diode | · | · | | | |
| V _F | forward voltage | I _F = 50 mA | 0.95 | 1.1 | V |
| I _R | reverse leakage current | V _R = 60 V | - | 100 | nA |
| C _d | diode capacitance | V _R = 0; f = 1 MHz | 0.42 | _ | pF |
| | | V _R = 1 V; f = 1 MHz | 0.375 | 0.45 | pF |
| | | V _R = 20 V; f = 1 MHz | 0.275 | 0.325 | pF |
| r _D | diode forward resistance | f = 100 MHz; note 1 | | | |
| | | I _F = 0.5 mA | 3.4 | 5.0 | Ω |
| | | $I_F = 1 \text{ mA}$ | 2.4 | 3.6 | Ω |
| | | I _F = 10 mA | 1.2 | 1.8 | Ω |
| | | I _F = 100 mA | 0.85 | 1.3 | Ω |
| s ₂₁ ² | isolation | V _R = 0; f = 900 MHz | 15.7 | _ | dB |
| | | V _R = 0; f = 1800 MHz | 10.5 | _ | dB |
| | | V _R = 0; f = 2450 MHz | 7.9 | _ | dB |
| S ₂₁ ² | insertion loss | I _F = 0.5 mA; f = 900 MHz | 0.27 | _ | dB |
| | | I _F = 0.5 mA; f = 1800 MHz | 0.35 | - | dB |
| | | I _F = 0.5 mA; f = 2450 MHz | 0.43 | - | dB |
| s ₂₁ ² | insertion loss | I _F = 1 mA; f = 900 MHz | 0.21 | - | dB |
| | | I _F = 1 mA; f = 1800 MHz | 0.29 | - | dB |
| | | I _F = 1 mA; f = 2450 MHz | 0.37 | - | dB |
| s ₂₁ ² | insertion loss | I _F = 10 mA; f = 900 MHz | 0.14 | - | dB |
| | | I _F = 10 mA; f = 1800 MHz | 0.21 | - | dB |
| | | I _F = 10 mA; f = 2450 MHz | 0.29 | - | dB |
| s ₂₁ ² | insertion loss | I _F = 100 mA; f = 900 MHz | 0.10 | - | dB |
| | | I _F = 100 mA; f = 1800 MHz | 0.18 | - | dB |
| | | I _F = 100 mA; f = 2450 MHz | 0.26 | - | dB |
| τ∟ | charge carrier life time | when switched from I _F = 10 mA to I _R = 6 mA; R _L = 100 Ω ; measured at I _R = 3 mA | 0.5 | - | μS |
| L _S | series inductance | I _F = 100 mA; f = 100 MHz | 1.4 | - | nH |

Note

1. Guaranteed on AQL basis: inspection level S4, AQL 1.0.

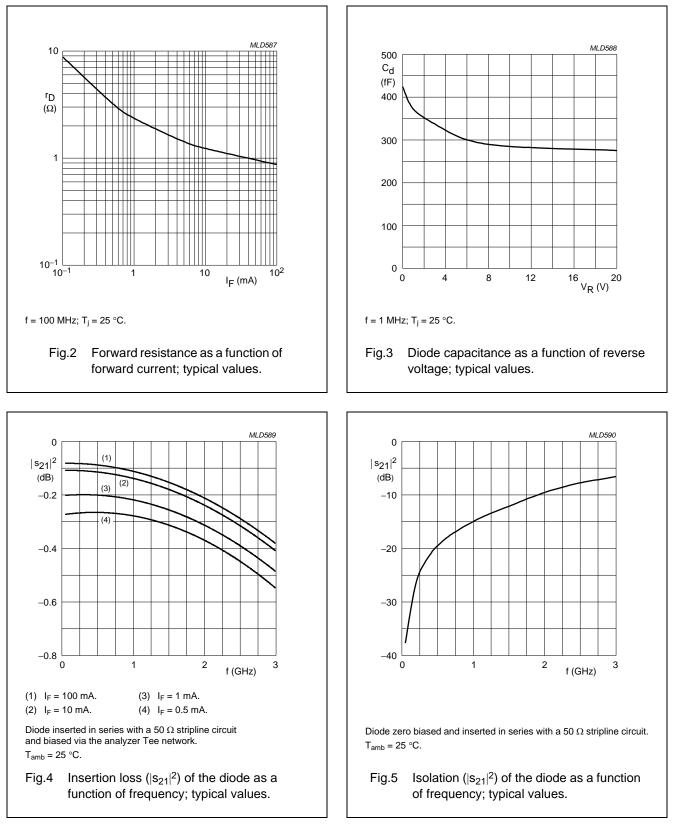
THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------------|---|-------|------|
| R _{th j-s} | thermal resistance from junction to soldering point | | K/W |

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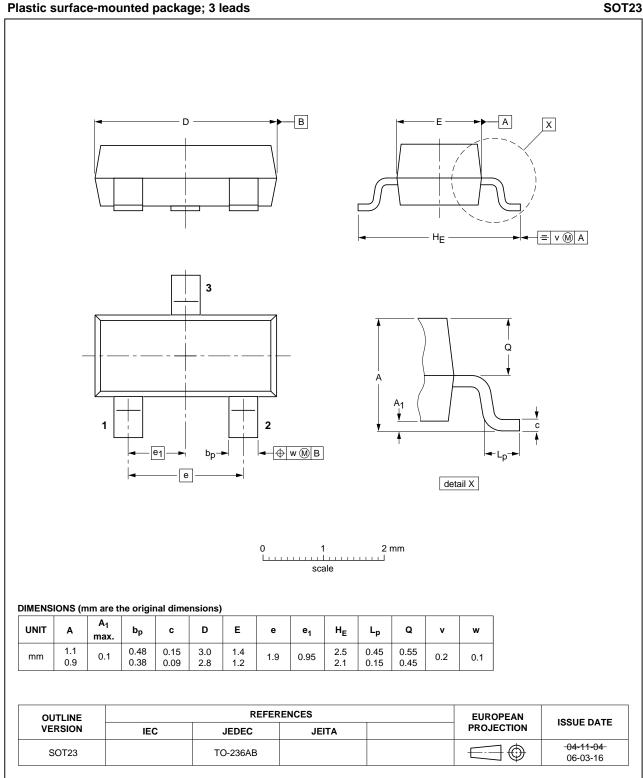




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Silicon PIN diode

PACKAGE OUTLINE



SOT23

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DATA SHEET STATUS

| DOCUMENT STATUS ⁽¹⁾ | PRODUCT STATUS ⁽²⁾ | DEFINITION |
|-----------------------------------|----------------------------------|---|
| Objective data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary data sheet | Qualification | This document contains data from the preliminary specification. |
| Product data sheet | Production | This document contains the product specification. |

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